## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | ASAO ET AL. | Examiner | Art Unit | Tran N. Nguyen | 2834 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2,516,140 A	07-1950	GUSTAVE NAHMAN	336/212
*	В	US-3,543,061 A	11-1970	WALLACE HENRY W	310/17
*	С	US-4,102,040 A	07-1978	Rich, Bernard J.	29/598
*	D	US-5,081,388 A	01-1992	Chen, Shew-Nen	310/266
*	Ε	US-2001/0015006 A1	08-2001	Vohlgemuth, Patrick	29/596
*	F	US-6,317,962 B1	11-2001	Adachi et al.	29/596
*	G	US-6,337,530 B1	01-2002	Nakamura et al.	310/258
*	Н	US-6,429,568 B1	08-2002	Shen et al.	310/254
*	ı	US-2004/0027027 A1	02-2004	Asao et al.	310/216
*	J	US-2006/0033397 A1	02-2006	Asao et al.	310/217
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N					
	0					
	Р	·				
	Q					1
	R					•
	s					
	Т					

## NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	•
	·w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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